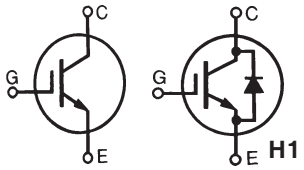
IXYS

High Voltage IGBT

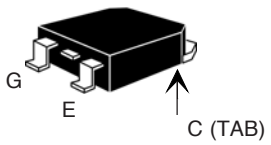
IXGH 16N170A
IXGT 16N170A
IXGH 16N170AH1
IXGT 16N170AH1

V_{CES} = 1700 V
I_{C25} = 16 A
$V_{CE(sat)}$ = 5.0 V
$t_{fi(typ)}$ = 70 ns

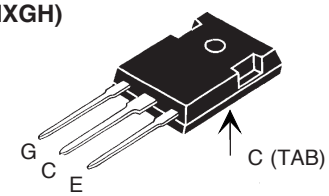
Preliminary Data Sheet



TO-268 (IXGT)



TO-247 (IXGH)



G = Gate C = Collector,
E = Emitter TAB = Collector

Symbol	Test Conditions		Maximum Ratings	
V_{CES}	T_J = 25°C to 150°C		1700	V
V_{CGR}	T_J = 25°C to 150°C; R_{GE} = 1 MΩ		1700	V
V_{GES}	Continuous		±20	V
V_{GEM}	Transient		±30	V
I_{C25}	T_C = 25°C		16	A
I_{C90}	T_C = 90°C		11	A
I_{F90}	T_C = 90°C, Diode		17	A
I_{CM}	T_C = 25°C, 1 ms		40	A
SSOA (RBSOA)	V_{GE} = 15 V, T_{VJ} = 125°C, R_G = 10Ω Clamped inductive load		I_{CM} = 40 @ 0.8 V_{CES}	A
t_{SC}	T_J = 125°C, V_{CE} = 1200 V; V_{GE} = 15 V, R_G = 22Ω		10	µs
P_C	T_C = 25°C		190	W
T_J			-55 ... +150	°C
T_{JM}			150	°C
T_{stg}			-55 ... +150	°C
M_d	Mounting torque (M3)	TO-247	1.13/10	Nm/lb.in.
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s			300	°C
Plastic body for 10s			260	°C
Weight		TO-247	6	g
		TO-268	4	g

Symbol	Test Conditions		Characteristic Values (T_J = 25°C, unless otherwise specified) min.	typ.	max.	
BV_{CES}	I_C = 250 µA, V_{GE} = 0 V		1700			V
$V_{GE(th)}$	I_C = 250 µA, V_{CE} = V_{GE}		3.0		5.0	V
I_{CES}	V_{CE} = 0.8 • V_{CES}	16N170A			50	µA
	V_{GE} = 0 V, Note 1	16N170AH1			100	µA
	T_J = 125°C	16N170A			750	µA
		16N170AH1			1.5	mA
I_{GES}	V_{CE} = 0 V, V_{GE} = ±20 V				±100	nA
$V_{CE(sat)}$	I_C = I_{C90}, V_{GE} = 15 V			4.0	5.0	V
		T_J = 125°C		4.8		V

Features
- High blocking voltage
- High current handling capability
- MOS Gate turn-on
  - drive simplicity
- Rugged NPT structure
- Molding epoxies meet UL 94 V-0 flammability classification
- SONIC-FRD™ fast recovery copack diode
- International standard packages JEDEC TO-268 and JEDEC TO-247 AD

Applications
- Capacitor discharge & pulser circuits
- AC motor speed control
- DC servo and robot drives
- DC choppers
- Uninterruptible power supplies (UPS)
- Switched-mode and resonant-mode power supplies

Advantages
- High power density
- Suitable for surface mounting
- Easy to mount with 1 screw, (isolated mounting screw hole)

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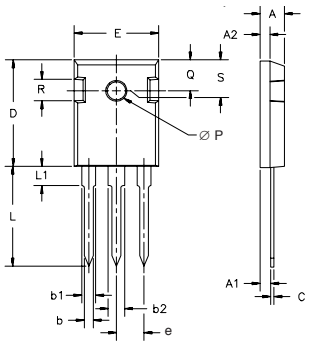
Symbol	Test Conditions (T_J = 25°C unless otherwise specified)		Characteristic Values min.	typ.	max.	
g_{fs}	$I_C = I_{C25}$; V_{CE} = 10 V, Note 2		7	13		S
C_{ies}				1620		pF
C_{oes}	V_{CE} = 25 V, V_{GE} = 0 V, f = 1 MHz	16N170A		83		pF
		16N170AH1		110		pF
C_{res}				31		pF
Q_g				83		nC
Q_{ge}	$I_C = I_{C90}$, V_{GE} = 15 V, V_{CE} = 0.5 V_{CES}			10		nC
Q_{gc}				31		nC
$t_{d(on)}$	**Inductive load, T_J = 25°C**			36		ns
t_{ri}	$I_C = I_{C25}$, V_{GE} = 15 V, R_G = 10 Ω			57		ns
$t_{d(off)}$	V_{CE} = 0.5 V_{CES}, Note 3			160	300	ns
t_{fi}				70	150	ns
E_{off}				0.85	1.5	mJ
$t_{d(on)}$	**Inductive load, T_J = 125°C**			38		ns
t_{ri}	$I_C = I_{C25}$, V_{GE} = 15 V, R_G = 10 Ω			59		ns
E_{on}	V_{CE} = 0.5 V_{CES}, Note 3	16N170A		1.5		mJ
		16N170AH1		2.5		mJ
$t_{d(off)}$				175		ns
t_{fi}				155		ns
E_{off}				2.0		mJ
R_{thJC}					0.65	K/W
R_{thCK}	(TO-247)			0.25		K/W

Reverse Diode (FRED) — **Characteristic Values**

Symbol	Test Conditions (T_J = 25°C unless otherwise specified)		min.	typ.	max.	
V_F	I_F = 20A, V_{GE} = 0 V, Note 2			2.5	2.9	V
		T_J = 125°C		2.5		V
t_{rr}	I_F = 20A, V_{GE} = 0 V, -di_F/dt = 450 A/µs			230		ns
	V_R = 1200 V	T_J = 125°C		400		ns
I_{RM}				23		A
		T_J = 125°C		27		A
R_{thJC}					0.9	K/W

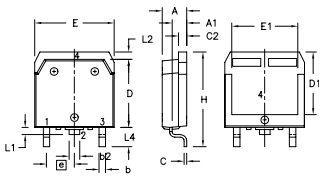
Notes: 1. Device must be heatsunk for high temperature leakage current measurements to avoid thermal runaway.
2. Pulse test, t ≤ 300 µs, duty cycle ≤ 2 %
3. Switching times may increase for V_{CE} (Clamp) > 0.8 • V_{CES}, higher T_J or increased R_G.

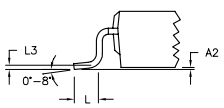
TO-247 AD Outline



Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	4.7	5.3	.185	.209
A_1	2.2	2.54	.087	.102
A_2	2.2	2.6	.059	.098
b	1.0	1.4	.040	.055
b_1	1.65	2.13	.065	.084
b_2	2.87	3.12	.113	.123
C	.4	.8	.016	.031
D	20.80	21.46	.819	.845
E	15.75	16.26	.610	.640
e	5.20	5.72	0.205	0.225
L	19.81	20.32	.780	.800
L1		4.50		.177
ØP	3.55	3.65	.140	.144
Q	5.89	6.40	0.232	0.252
R	4.32	5.49	.170	.216
S	6.15 BSC		242 BSC	

TO-268 Outline





Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	4.9	5.1	.193	.201
A_1	2.7	2.9	.106	.114
A_2	.02	.25	.001	.010
b	1.15	1.45	.045	.057
b_2	1.9	2.1	.75	.83
C	.4	.65	.016	.026
D	13.80	14.00	.543	.551
E	15.85	16.05	.624	.632
E_1	13.3	13.6	.524	.535
e	5.45 BSC		.215 BSC	
H	18.70	19.10	.736	.752
L	2.40	2.70	.094	.106
L1	1.20	1.40	.047	.055
L2	1.00	1.15	.039	.045
L3	0.25 BSC		.010 BSC	
L4	3.80	4.10	.150	.161

IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6771478 B2

Fig. 1. Output Characteristics @ 25 ºC

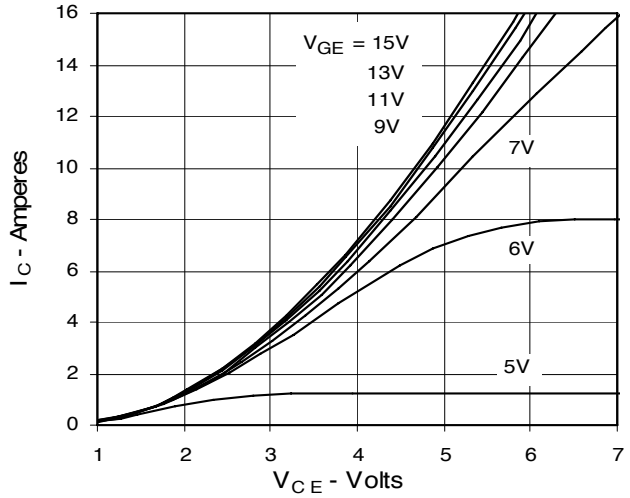


Fig. 2. Extended Output Characteristics @ 25 ºC

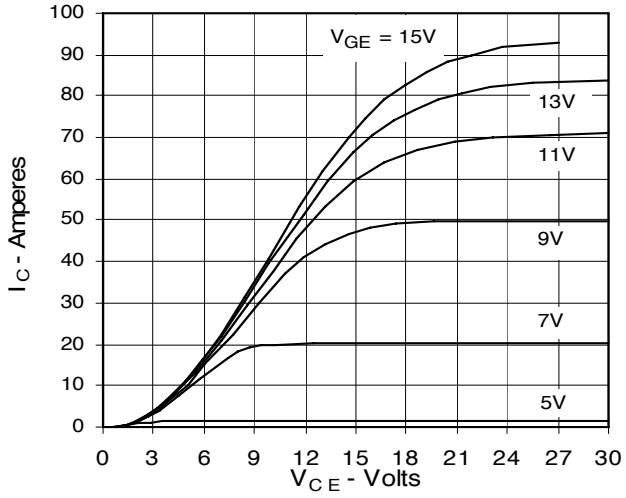


Fig. 3. Output Characteristics @ 125 ºC

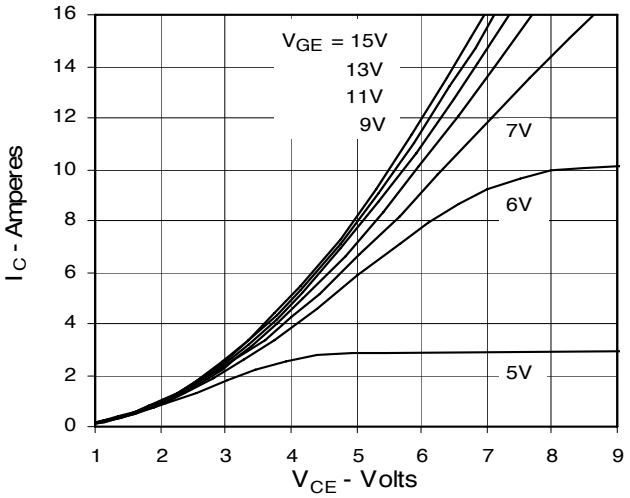


Fig. 4. Dependence of $V_{CE(sat)}$ on Temperature

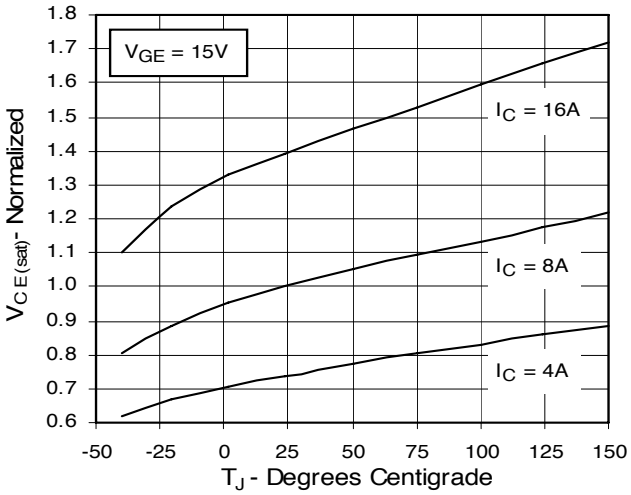


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter voltage

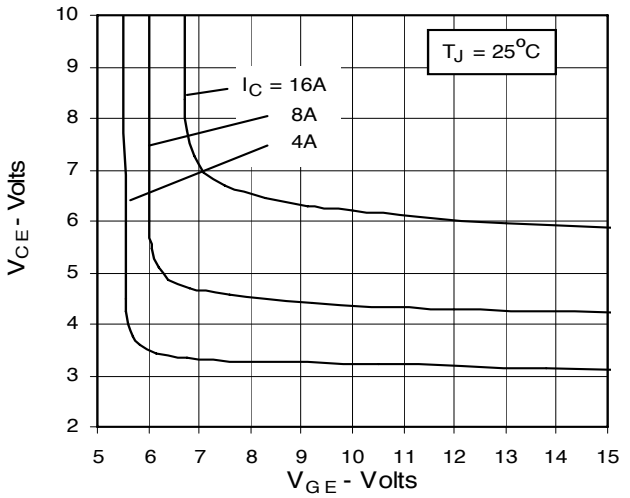


Fig. 6. Input Admittance

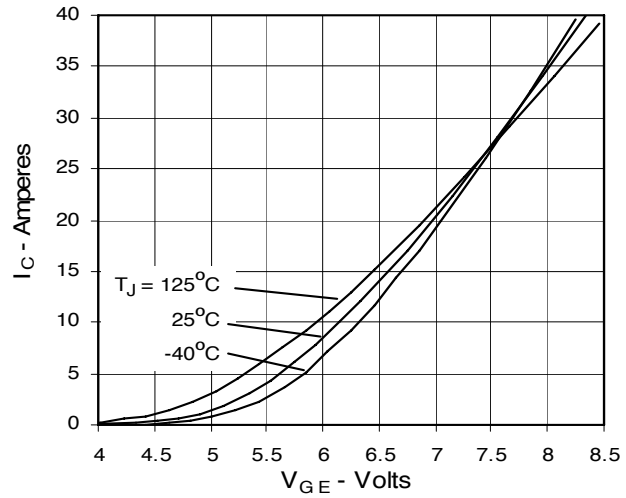


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Fig. 7. Transconductance

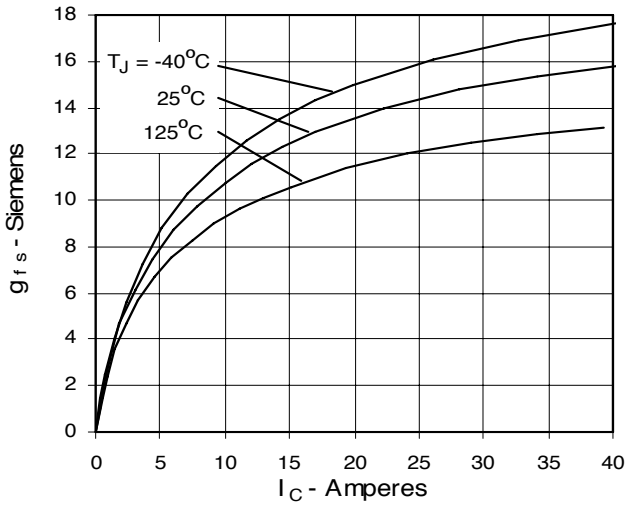


Fig. 8. Dependence of Turn-off Energy Loss on R_G

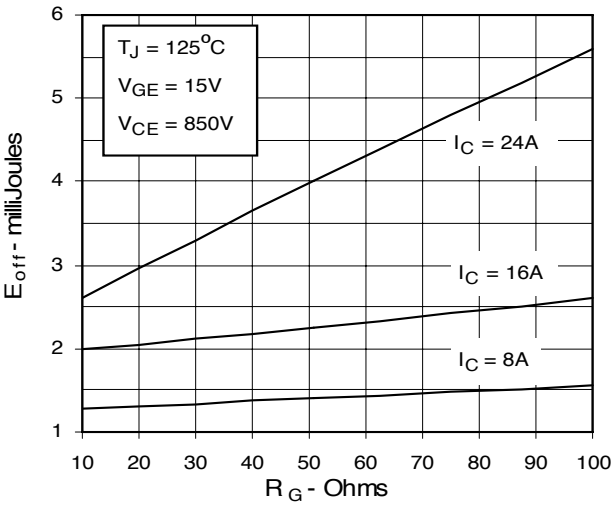


Fig. 9. Dependence of Turn-Off Energy Loss on I_C

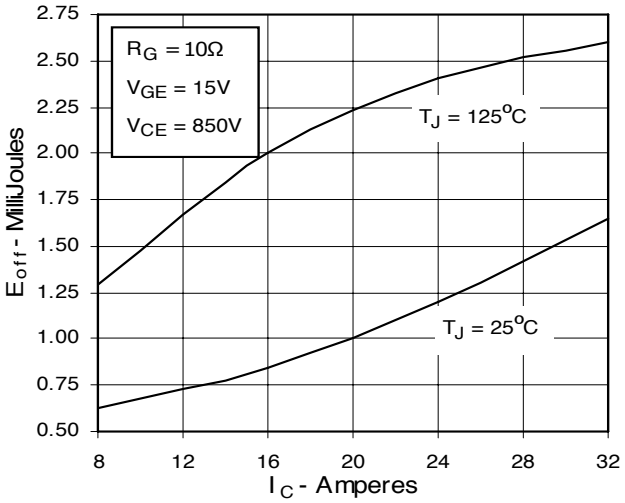


Fig. 10. Dependence of Turn-off Energy Loss on Temperature

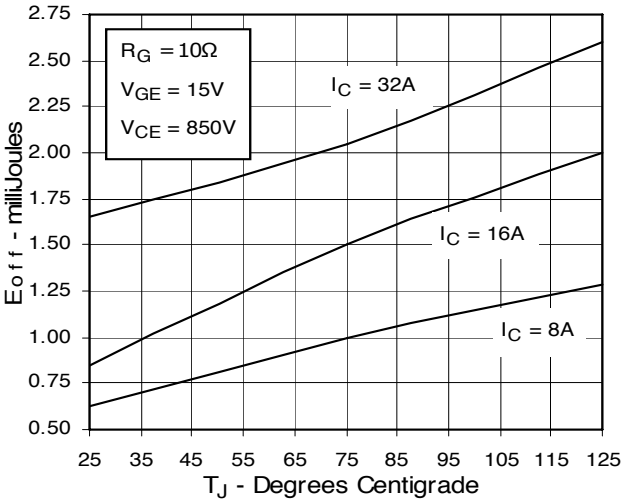


Fig. 11. Dependence of Turn-off Switching Time on R_G

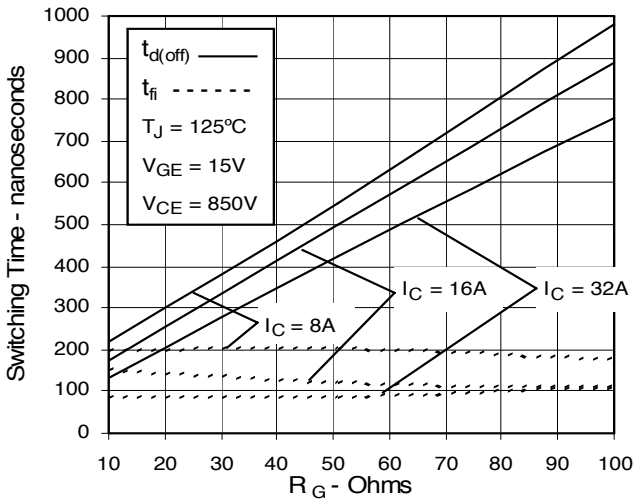
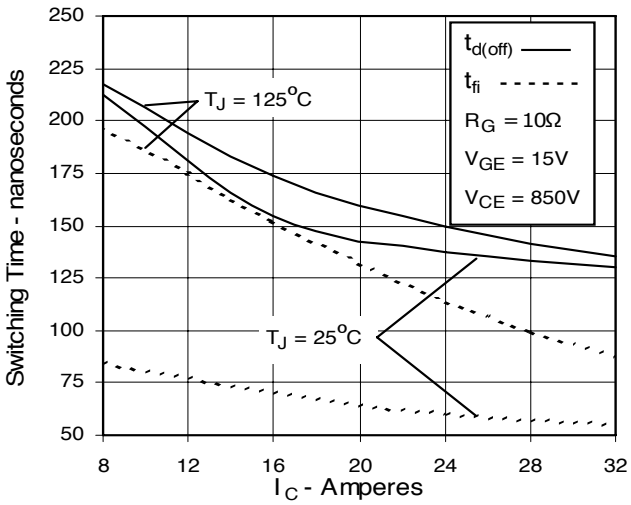


Fig. 12. Dependence of Turn-off Switching Time on I_C



IXYS reserves the right to change limits, test conditions, and dimensions.

Fig. 13. Dependence of Turn-off Switching Time on Temperature

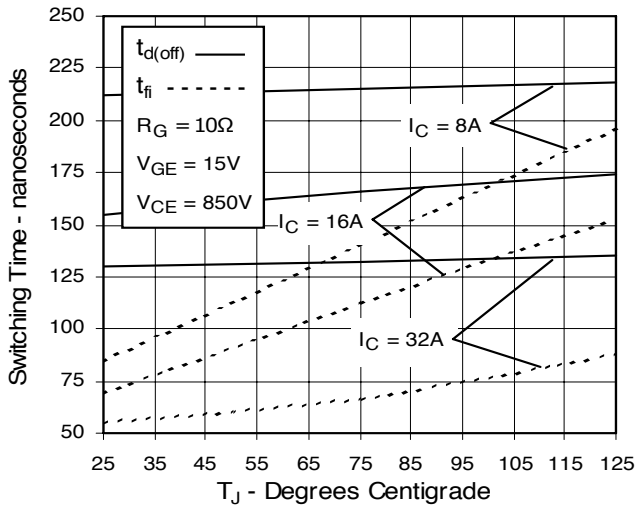


Fig. 14. Gate Charge

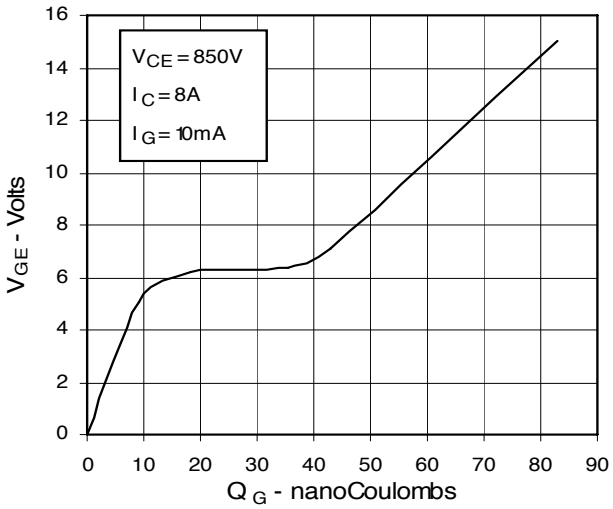


Fig. 15. Capacitance

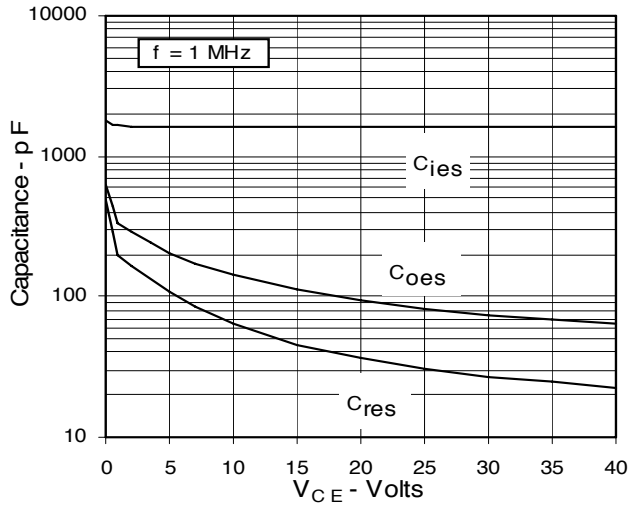


Fig. 16. Reverse-Bias Safe Operating Area

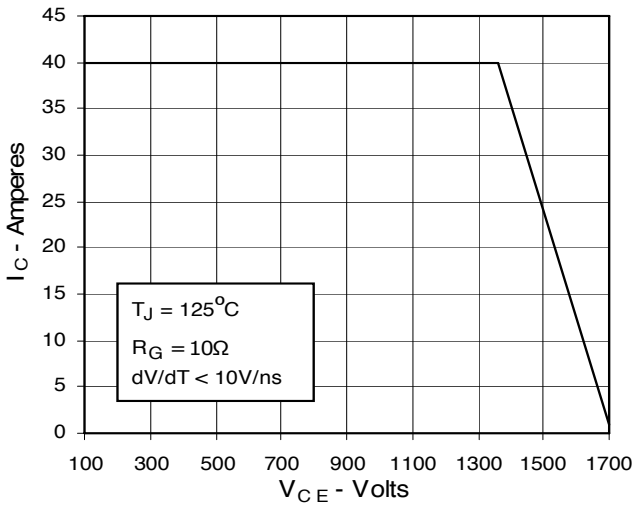
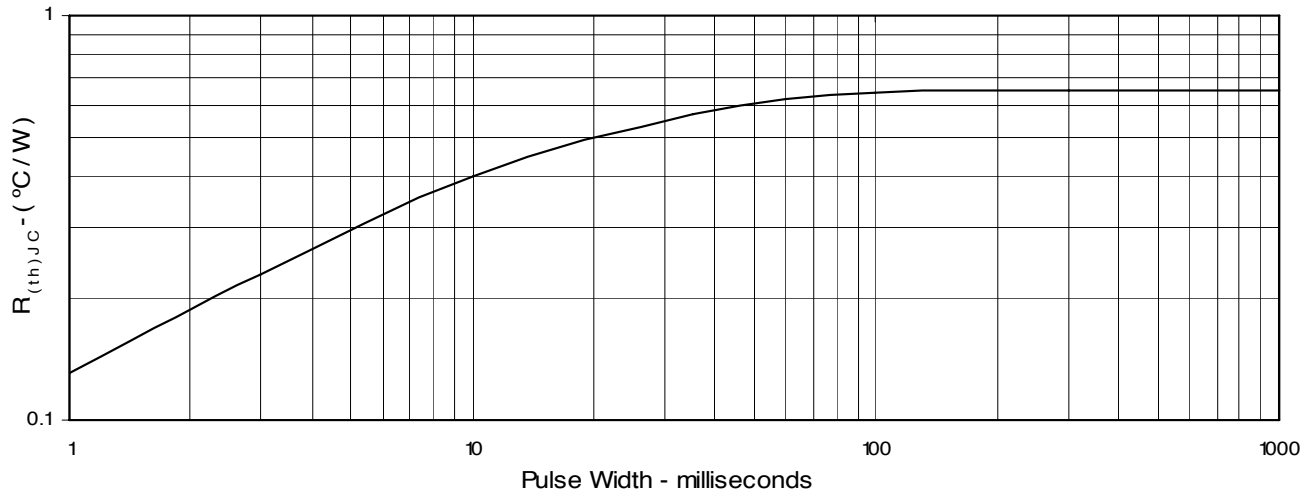


Fig. 17. Maximum Transient Thermal Resistance



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PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a subjective pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.